

# **Notice of References Cited**

Application/Control No.

10/572,187

Applicant(s)/Patent Under  
Reexamination  
JONES ET AL.

Examiner

COLLEEN M. RAPHAEL

Art Unit

1724

Page 1 of 1

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Hawley's Condensed Chemical Dictionary, 14 ed., John Wiley & Sons 2002, definition of anion
	V	Hawley's Condensed Chemical Dictionary, 14 ed., John Wiley & Sons 2002, definition of cation
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.